

PATENT NUMBER

U.S. UTILITY Patent Application

NAME

PATENT DATE

10/10/00

APPLICATION NO.	CONT/PRIOR	CLASS	SUBCLASS	ART UNIT	EXAMINER
09/955517	218	156	599	1746	Hassanzadeh

APPLICANTS

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315,5 1763

TITLE

In-situ or ex-situ profile monitoring of phase openings on
 alternating phase shifting masks by scatterometry

PTO-2040
12/99

EXAMINATION

CROSS REFERENCE(S)

SEARCH CLASS (ONE SUBCLASS PER BLOCK)

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DRAWINGS

CLAIMS ALLOWED

FIG. DRAW.	PAGE DRAW.	PRINT FIG.

Total Claims	Print Claim for O.G.
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NOTICE OF ALLOWANCE MAILED

(Assistant Examiner)	(Date)

ISSUE FEE	
Amount Due	Date Paid

(Primary Examiner)	(Date)
(Legal Instruments Examiner)	(Date)

ISSUE BATCH NUMBER

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